

EECS 170A Section B Midterm Exam Solution

Fall 2007 – Prof. Burke

Note: No credits will be given to any answers without units.

PROBLEM ONE: (30 points)

A Si semiconductor is doped at $N_A = 10^{16} \text{ cm}^{-3}$.

A) Find the density of holes.

Assume $T = 300\text{K}$, $n_i = 10^{10} \text{ cm}^{-3}$

Since $N_D \ll N_A$ and $n_i \ll N_A$, the concentration of holes:

$$\therefore p \approx N_A = 10^{16} \text{ cm}^{-3}$$

(Correct steps, wrong answer: 10 points;
Correct answer: 15 points)

B) Find the density of electrons.

$$n = \frac{n_i^2}{N_A} = \frac{(10^{10})^2}{10^{16}} = 10^4 \text{ cm}^{-3}$$

(Only correct equation: 5 points;
Correct steps, wrong answer: 10 points;
Correct answer: 15 points)

PROBLEM TWO: (30 points)

An on-chip resistor is to be made of n-doped silicon, with dimensions $10 \mu\text{m}$ long, $1 \mu\text{m}$ wide, and $0.1 \mu\text{m}$ thick. The desired resistance is $1 \text{ M}\Omega$. What doping level should be used?

Assumption: $T = 300\text{K}$

Given: Resistance, $R = 1 \text{ M}\Omega = 10^6 \Omega$

Length, $L = 10 \mu\text{m} = 10^{-3} \text{ cm}$

Width, $W = 1 \mu\text{m} = 10^{-4} \text{ cm}$

Thickness, $H = 0.1 \mu\text{m} = 10^{-5} \text{ cm}$

$$\therefore \text{ Resistivity, } \rho = \frac{RA}{L} = \frac{10^6 \times 10^{-4} \times 10^{-5}}{10^{-3}} = 1\Omega/cm^{-3}$$

(Only correct equation: 2 points;

Correct equation with right value substitution, but wrong answer: 10 points;

Correct answer with wrong unit or wrong unit conversion: 13 points

Correct answer with correct unit and right unit conversion: 15 points)

We want to make the resistor from n-doped silicon, therefore we assume that $N_D \gg N_i$ and $N_D \gg N_A$:

$$\rho \approx \frac{1}{qn\mu_n} = 1\Omega/cm^{-3} \Rightarrow \mu_n = \frac{1}{qn} (cm^2/V.s)$$

Use Figure on Page 1 and iteration to find the doping level:

$$\text{Try } N_D = 10^{16} \text{ cm}^{-3}:$$

$$\mu_n = \frac{1}{qn} = \frac{1}{(1.6 \times 10^{-19}) \times 10^{16}} = 0.625 \times 10^3 = 625 \text{ cm}^2/V.s$$

It's smaller than the $\mu_n = 1010 \text{ cm}^2/V.s$ obtained from the graph.

$$\text{Try } N_D = 10^{15} \text{ cm}^{-3}:$$

$$\mu_n = \frac{1}{qn} = \frac{1}{(1.6 \times 10^{-19}) \times 10^{15}} = 0.625 \times 10^4 = 6250 \text{ cm}^2/V.s$$

It's larger than the $\mu_n = 1020 \text{ cm}^2/V.s$ obtained from the graph.

$$\text{Try } N_D = 6 \times 10^{15} \text{ cm}^{-3}:$$

$$\mu_n = \frac{1}{qn} = \frac{1}{(1.6 \times 10^{-19}) \times (6 \times 10^{15})} = 0.104 \times 10^4 = 1040 \text{ cm}^2/V.s$$

It's very close to the $\mu_n = 1020 \text{ cm}^2/V.s$ obtained from the graph.

Since $N_D = 6 \times 10^{15} \text{ cm}^{-3} \gg N_i$ and $N_D \gg N_A$, so our assumptions are valid.

\therefore The required doping level, $N_D \approx 6 \times 10^{15} \text{ cm}^{-3}$

(Accepted doping level range: $5 \times 10^{15} \text{ cm}^{-3} \leq N_D \leq 7 \times 10^{15} \text{ cm}^{-3}$)

(Only correct equation: 2 points;

Correct equation with only one iterative step, but wrong answer: 7.5 points;

Correct equation with iterative steps shown, but wrong answer: 10 points;

Correct equation with iterative steps shown and correct answer: 15 points)

PROBLEM THREE: (40 points)

Concentration questions with a twist.

- A) A semiconductor is doped with an impurity concentration of N such that $N \gg n_i$ and all the impurities are ionized. Also, $n = N$ and $p = n_i^2/N$. Is the impurity a donor or an acceptor? Explain.

Since the electron concentration approximately equals to the doping concentration (N), and $N \gg n_i$, the impurity must be a donor in order to increase the electron concentration much higher than the intrinsic carrier concentration.

(Stating "Donor": 5 points
Stating "Electron concentration = doping concentration": 2.5 points
Stating "Electron concentration \gg intrinsic carrier concentration" or "Donor donates electrons": 2.5 points)

- B) The electron concentration in a piece of Si at 300 K under equilibrium conditions is $10^{15}/\text{cm}^3$. What is the hole concentration?

$$\begin{aligned} \text{At } T=300\text{K}, n_i &= 10^{10} \text{ cm}^{-3} \\ \text{Given: } n &= 10^{15} \text{ cm}^{-3}: \\ \therefore p &= \frac{n_i^2}{n} = \frac{(10^{10})^2}{10^{15}} = 10^5 \text{ cm}^{-3} \end{aligned}$$

(Only correct equation: 2 points
Correct steps, wrong answer: 8 points
Correct answer: 10 points)

- C) For a silicon sample maintained at $T=300$ K, the Fermi level is located 0.259 eV above the intrinsic Fermi level. What are the electron and hole concentrations?

$$\begin{aligned} n &= n_i e^{(E_F - E_i)/KT} = 10^{10} e^{(0.259/0.0259)} = 10e^{10} \text{ cm}^{-3} \\ p &= n_i e^{(E_i - E_F)/KT} = 10^{10} e^{-(0.259/0.0259)} = 10e^{-10} \text{ cm}^{-3} \end{aligned}$$

Or use $np = n_i^2$ to find the other carrier concentration when one carrier concentration is already calculated.

(Only correct equations: 2 points
Correct steps, wrong answer: 4 points for each n and p ;
(Correct answer: 5 points for each n and p)

D) In a nondegenerate germanium sample maintained under equilibrium conditions near room temperature, it is known that $n_i=10^{13}/\text{cm}^3$, $n=10,000p$, and $N_A=0$. Determine n and N_D .

$$n = 10000p \dots\dots\dots(\text{Eqn. 1})$$

$$np = n_i^2 \dots\dots\dots(\text{Eqn. 2})$$

Substitute Eqn. 1 into Eqn. 2:

$$10000p^2 = n_i^2 = (10^{13})^2 \Rightarrow p = 10^{11} \text{ cm}^{-3}$$

$$\therefore n = 10^{15} \text{ cm}^{-3}$$

From charge neutrality relationship:

$$p + N_D = n + N_A$$

$$\therefore N_D = 10^{15} + 0 - 10^{11} \approx n = 10^{15} \text{ cm}^{-3}$$

(Only correct equations: 2 points

Correct steps, wrong answer: 4 points for each n and N_D ;

Correct answer: 5 points for each n and N_D)